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CLAIMS

- Polycrystalline gallium nitride (GaN), wherein the atomic fraction of gallium 1. ranges from between about 49% to 55%, an apparent density of between about 5.5 and 6.1 g/cm³, and a Vickers hardness of above about 1 GPa.
- The GaN of claim 1, which has a thickness or minimum dimension of 2. 5 between about 0.2 mm and 1 m.
 - The GaN of claim 1, which has a diameter or maximum dimension of 3. between about 1 mm and 1 m.
 - The GaN of claim 1, which has equiaxed grains with an average size of 4. between about 0.01 and 50 µm.
 - The GaN of claim 1, having surfaces that are substantially smooth, with a 5. root-mean-square roughness below about 100 μm.
 - The GaN of claim 5, having surfaces that are substantially smooth, with a 6. root-mean-square roughness below about 20 μm.
- A method for making sintered polycrystalline gallium nitride (GaN), which 7. 20 comprises the steps of:
 - enclosing and sealing GaN as one or more of powder or a cold-(a) pressed pill, in a non-metallic container;
 - subjecting said container to hot isostatic pressing (HIPing) at a (b) temperature ranging from about 1150° C to 1300° C and a pressure ranging from between about 1 and 10 Kbar; and
 - recovering polycrystalline GaN from said container. (c)
 - The method of claim 7, wherein said non-metallic container is evacuated of 8. air prior to sealing. 30
 - The method of claim 7, wherein said HIPing is conducted for a time ranging 9. from about 2 minutes to about 24 hours.
 - The method of claim 7, wherein said recovering step includes grinding off 10. 35 the container from said sintered polycrystalline GaN.

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- 11. The method of claim 7, wherein said sintered polycrystalline GaN has a thickness or minimum dimension of between about 0.2 mm and 1 m.
- The method of claim 7, wherein said sintered polycrystalline GaN has a diameter or maximum dimension of between about 1 mm and 1 m.
 - 13. The method of claim 7, wherein said sintered polycrystalline GaN has equiaxed grains with an average size of between about 0.01 and 50 μm .
 - 14. The method of claim 7, wherein said sintered polycrystalline GaN has surfaces, which are substantially smooth, with a root-mean-square roughness below about 100 μm.
- 15 15. The method of claim 14, wherein said sintered polycrystalline GaN has surfaces, which are substantially smooth, with a root-mean-square roughness below about 20 µm.
 - 16. The method of claim 7, wherein said GaN enclosed in said container is a powder.
 - 17. The method of claim 7, wherein said GaN enclosed in said container is a cold-pressed pill.
- 25 18. A method for making sintered polycrystalline gallium nitride (GaN), which comprises the steps of:
 - (a) placing GaN as one or more of powder or a cold-pressed pill in a high pressure/high temperature (HP/HT) reaction cell;
 - (b) placing said reaction cell in a HP/HT apparatus;
- 30 (c) subjecting said container to a temperature ranging from about 1200° to 1800° C and a pressure ranging from about 5 to 80 Kbar, and
 - (d) recovering polycrystalline GaN from said reaction cell.
- The method of claim 18, wherein step (c) is conducted for a time ranging from about 2 minutes to about 24 hours.

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- 20. The method of claim 18, wherein said recovering step includes grinding.
- 21. The method of claim 18, wherein said sintered polycrystalline GaN has a thickness or minimum dimension of between about 0.2 mm and 1 m.
- 22. The method of claim 18, wherein said sintered polycrystalline GaN has a diameter or maximum dimension of between about 1 mm and 1 m.
- The method of claim 18, wherein said sintered polycrystalline GaN has
 equiaxed grains with an average size of between about 0.01 and 50 μm.
 - 24. The method of claim 18, wherein said sintered polycrystalline GaN has surfaces, which are substantially smooth, with a root-mean-square roughness below about 100 μm.
 - 25. The method of claim 24, wherein said sintered polycrystalline GaN has surfaces that are substantially smooth, with a root-mean-square roughness below about 20 μm.
- 20 26. The method of claim 18, wherein said GaN enclosed in said container is a powder.
 - The method of claim 18, wherein said GaN enclosed in said container is a cold-pressed pill.